#### TOSHIBA PHOTOCOUPLER GaAlAs IRED & PHOTO-IC

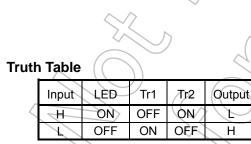
# **TLP108**

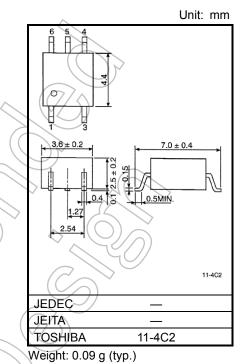
# Isolated bus drivers High speed line receivers Microprocessor system interfaces

The Toshiba TLP108 consists of a GaAlAs light emitting diode optically coupled to a high-gain, high-speed photodetector. The TLP108 is housed in a 6-pin MFSOP. With a totem-pole output, the TLP108 is capable of both sinking and sourcing current. The TLP108 has an internal Faraday shield, which provides a guaranteed common-mode transient immunity. The TLP108 has an inverting output. A noninverting-output version, the TLP105, is also available.

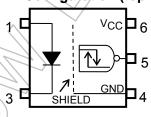
- Inverter logic type (totem-pole output)
- Guaranteed Performance Over temperature: -40 to 100°C
- Power Supply Voltage: 4.5 to 20 V
- Input Threshold Current: I<sub>FHL</sub> =1.6 mA (max)
- Switching Time (t<sub>pLH</sub>/t<sub>pHL</sub>): 250 ns (max)
- Common mode transient immunity: 10 kV/µs
- Isolation Voltage: 3750 Vrms
- UL approved : UL1577, File No.E67349
- c-UL approved :CSA Component Acceptance Service No. 5A, File No.E67349

 Option (V4) VDE approved - DIN EN60747-5-5 (Note) (Note) : When an EN60747-5-5 approved type is needed, Please designate "Option(V4)"

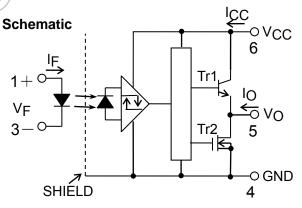




#### Pin Configuration (top View)



1:ANODE 3:CATHODE 4:GND 5:V<sub>O</sub>(Output) 6:V<sub>CC</sub>



0.1  $\mu$ F bypass capacitor must be connected between pin 6 and 4.

Start of commercial production 2008-04

### **Recommended Operating Conditions**

CHARACTERISTIC	SYMBOL	MIN	TYP.	MAX	UNIT	
Input Current , ON	l <sub>F(ON)</sub>	2		10	mA	
Input Voltage , OFF	V <sub>F(OFF)</sub>	0	_	0.8	V	
Supply Voltage*	V <sub>CC</sub>	4.5		20	V	
Operating Temperature	Topr	-40	_	100	°C	
Fan-out (TTL Load)	N	_	_	4	_	

\* This item denotes operating range, not meaning of recommended operating conditions.

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

	CHARACTERISTIC	SYMBOL	RATING	UNIT	
	Forward Current		) 20 🛇	mA	
	Forward Current Derating (Ta ≥ 83°C)	∆F/℃	-0.48		
LED	Peak Transient Forward Current (Note 1)	IFPT	1 ((	A	
	Input Power Dissipation	PD	40	mA mA/°C A mW V mA mA/°C mA V mW V v c °C °C	
	Reverse Voltage	∨ V <sub>R</sub>	(57/	>	
	Output Current 1 (Ta ≤ 25°C)	l01	25/-15	mA	
	Output Current 2 (Ta ≤ 100°C)	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	mA		
DETECTOR	Output Current Derating (Ta ≥ 25°C)	∆ <sub>01</sub> /°C	-0.26/-0.13	mA mA/°C A mW V mA mA/°C mA V mW V v mW V °C °C °C	
ĽC	Peak Output Current (Note 2)	I <sub>OP</sub>	50/-50	mA	
DEI	Output Voltage	Vo	-0.5 to 20	V	
	Output Power Dissipation	Ro	75	mA mA/°C A mW V mA mA/°C mA V mW V v c °C °C	
	Supply Voltage	VCC	-0.5 to 20	mA mA/°C A mW V mA mA/°C mA V mW V v c °C °C	
Oper	rating Temperature Range	Topr	-40 to 100	°C	
Stora	age Temperature Range	T <sub>stg</sub>	-55 to 125	°C	
Lead	Solder Temperature (10 s)	T <sub>sol</sub>	260	mW 0 V 0 °C 5 °C	
	tion Voltage (AC, 60 s, R.H. $\leq$ 60 %) (Note 3)	вv <sub>s</sub>	3750	V <sub>rms</sub>	

#### A

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Pulse width  $\leq 1 \mu s$ , 300pps.

Note 2: Pulse width  $\leq 5\mu s$ , duty cycle  $\leq 0.025$ 

Note 3: Device considered a two terminal device: pins 1 and 3 shorted together and pins 4, 5 and 6 shorted together.

#### Electrical Characteristics (Unless otherwise specified, Ta = -40 to 100°C, V<sub>CC</sub> = 4.5 to 20 V)

CHARACTERISTIC	SYMBOL	TEST CIRCUIT	CONDITION		MIN	TYP.	MAX	UNIT	
Input Forward Voltage	VF	_	I <sub>F</sub> =10 mA, Ta=25°C		1,45	1.57	1.75	V	
Temperature Coefficient of Forward Voltage	ΔV <sub>F</sub> /ΔTa		I <sub>F</sub> =10 mA			-2.0		mV/°C	
Input Reverse Current	IR	_	V <sub>R</sub> =5 V, Ta=25	°C		Ľ	10	μA	
Input Capacitance	CT	_	V=0V, f=1 MHz	, Ta=25°C	074SS	100	_	pF	
Logic Low Output Voltage	V <sub>OL</sub>	1	I <sub>OL</sub> =3.5 mA , I	==5 mA		0.2	0.6	V	
		V <sub>OH</sub> 2	I <sub>OH</sub> =-2.6 mA,	V <sub>CC</sub> =4.5 V	2.7	4.0	-		
Logic High Output Voltage	VOH		V <sub>F</sub> =0.8 V	V <sub>CC</sub> =20-V	17.4	19.0		V	
Logic Low Supply Current	ICCL	3	I <sub>F</sub> =5 mA	V <sub>CC</sub> =20 V		de la	3.0		
				V <sub>CC</sub> =5.5 V	(	6	3.0	mA	
Logic High Supply Current	<sup>I</sup> ССН	4	V <sub>F</sub> =0 V	V <sub>CC</sub> =20 V		SI/	) 3.0	mA	
				V <sub>CC</sub> =5.5 V			3.0		
Logic Low Short Circuit		-	I <sub>F</sub> =5 mA	V <sub>CC</sub> =V <sub>O</sub> =5.5 V	(15)	80	-		
Output Current (Note 1)	IOSL	5	VO=GND	V <sub>CC</sub> =V <sub>O</sub> =20 V	20	90	_	mA	
Logic High Short Circuit				V <sub>CC</sub> =5.5 V	75	-15			
Output Current (Note 1)	IOSH	6	V <sub>F</sub> =0 V	V <sub>CC</sub> =20 V	-10	-20	_	mA	
Input Current Logic Low Output	IFHL	$(\bigcirc$	I <sub>O</sub> =3.5 mA, V <sub>C</sub>	o<0.4 V		0.4	1.6	mA	
Input Voltage Logic High Output	V <sub>FLH</sub>	$(\mathcal{F})$	I <sub>O</sub> =-2.6 mA, V <sub>O</sub> >2.4 V		0.8	_	_	V	
Input Current Hysteresis	IHYS7		V <sub>CC</sub> =5 V		_	0.05	_	mA	

\*All typical values are at Ta=25°C

Note 1: Duration of output short circuit time should not exceed 10 ms.

# Isolation Characteristics (Ta = 25°C)

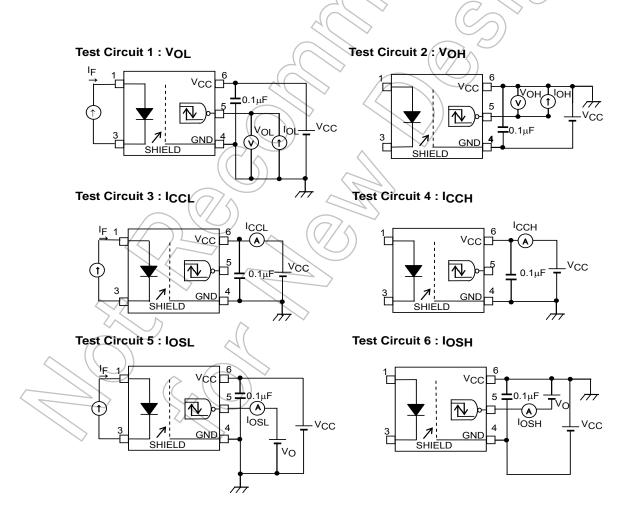
			1			
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Capacitance input to output	CS	V <sub>S</sub> = 0V,f = 1 MHz (Note 1)	—	0.8	_	pF
Isolation resistance	RS	${\sf R.H.} \le 60\%, {\sf VS} = 500 \; {\sf V} \qquad ({\sf Note} \; 1)$	1×10 <sup>12</sup>	10 <sup>14</sup>	-	Ω
	$( \bigcirc ) \checkmark$	AC,60 s	3750	-	-	V
Isolation voltage	BVS	AC,1 s in oil	_	10000	-	V <sub>rms</sub>
		DC,60 s, in oil	_	10000	_	V <sub>dc</sub>

Note 1: A ceramic capacitor (0.1µA) should be connected from pin 6 to pin 4 to stabilize the operation of the high gain linear amplifier. Failure to provide the bypassing may impair the switching property. The total lead length between capacitor and coupler should not exceed 1 cm.

#### Switching Characteristics (Unless otherwise specified, Ta = -40 to 100°C, V<sub>CC</sub> = 4.5 to 20 V)

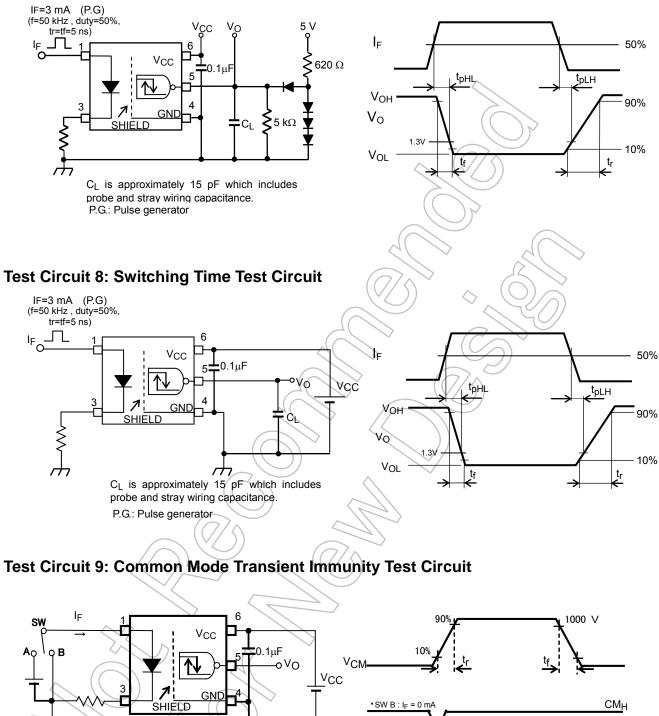
CHARACTERISTIC	SYMBOL	TEST CIRCUIT	CONDITION	MIN	TYP.	MAX	UNIT
Propagation Delay Time to Logic High output	<sup>t</sup> pLH		I <sub>F</sub> =3→0mA	30 <	150	250	ns
Propagation Delay Time to Logic Low output	<sup>t</sup> pHL		IF=0→3mA	30	150	250	ns
Switching Time Dispersion between ON and OFF	lt <sub>pHL</sub> - t <sub>pLH</sub> l	7, 8	-	$\overline{\langle}$	<u></u>	220	ns
Rise Time (10 – 90 %)	tr		I <sub>F</sub> =3→0mA, V <sub>CC</sub> =5V		30	75	ns
Fall Time (90 – 10 %)	tf		I <sub>F</sub> =0→3mA, V <sub>CC</sub> =5V	- T	30	75	ns
Common Mode transient Immunity at High Level Output	СМ <sub>Н</sub>		V <sub>CM</sub> =1000V <sub>p-p</sub> , I <sub>F</sub> =0mA, V <sub>CC</sub> =20V,Ta=25°C	-10000	-		V/μs
Common Mode transient Immunity at Low Level Output	CML	9	V <sub>CM</sub> =1000V <sub>p-p</sub> , I <sub>F</sub> =5mA, V <sub>CC</sub> =20V,Ta=25°C	10000	Å	$\mathbb{A}$	V/μs

\*All typical values are at Ta=25°C



# Test Circuit 7: Switching Time Test Circuit

VCM



 $V_{O}$  17 V $SWA: I_{F} = 5 mA$   $M_{L}$ 

$$CM_{H} = \frac{800(V)}{t_{f}(\mu s)}$$
  $CM_{L} = \frac{800(V)}{t_{r}(\mu s)}$ 

H

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